

386-1, Ho-Dong, Yongin-City, Kyungki-Do, Korea 449-100
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### **EMC TEST REPORT For FCC**

Test Report No. : CTK02-F038

Date of Issue : July 31, 2002

Model/Type No: : HB-100K

Kind of Product : Braille PDA

Applicant : HIMS Korea Co., Ltd.

Applicant Address : High-Tech Venture Hall 5105, 53-3, Eoeun-dong,

Yuseong-ku, Daejeon, KOREA

Manufacturer : HIMS Korea Co., Ltd.

Manufacturer Address : High-Tech Venture Hall 5105, 53-3, Eoeun-dong,

Yuseong-ku, Daejeon, KOREA

Contact Person : Kyeong Seon CHOI (Manager)

Telephone : +82-42-864-4460

Received Date : March 22, 2002

Test period : Start: March 23, 2002 End: July 27, 2002

Test Results : X In Compliance In Not in Compliance

The test results presented in this report relate only to the object tested.

CERTITEK Standards Laboratory Co., Ltd. is accredited by Korea Laboratory Accreditation Scheme (KOLAS) which signed the International Laboratory Accreditation Cooperation (ILAC) Mutual Recognition Arrangement (MRA) for the above test item(s) and test method(s).

Tested by

Michael Jang

EMC Test Engineer Date: July 31, 2002

Reviewed by

J. 14

James Hong

EMC Technical Manager Date: July 31, 2002

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### REPORT REVISION HISTORY

Date	Revision	Page No
July 31, 2002	Issued (CTK02-F038)	All

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### 1.0 General Product Description

#### 1.0.1 Tested Equipment

	$\boxtimes$	Unless otherwise indicated, all tests were conducted Model HB-100K.						
		erformed on Model were considered to be entative of Model(s)						
1.0.2	Equip	ment S	ize, Mobility and Identification					
	Dimens Mobility		Approx. 15.0 by 25.3 by 5.8 ☐ cm ☐ in ☐ Hand-Held ☐ Table-top ☐ Floor-standing ☐ -					
	Serial N	No.:	Not applicable					
1.0.3	Electr	ical Ra	tings					
	Input:		Adaptor - AC 100V, 50/60Hz, 22VA EUT - DC 5V, 1.5A					
	Output	:	Adaptor – DC 5V, 1.5A EUT – Not applicable					

### 1.0.4 Test Voltage & Frequency

Unless indicated otherwise on the individual data sheet or test results, the test voltage and frequency was as indicated below.

Voltage: AC 110V Frequency: 60Hz

### 1.0.5 Clock & Other Frequencies Utilized

Main - 3.6864MHz Real time - 32kHz System - 103MHz LAN - 20MHz Parallel - 14.31818MHz VGA - 12.288MHz Audio - 8.192MHz, 11.2896MHz

### 1.1 Model Differences

Not applicable

### 1.2 Device Modifications

The following modifications were necessary for compliance:

Not applicable

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### 1.3 EUT Configuration(s)

See Appendix A for individual test set-up configuration(s). The following peripheral devices and/or interface cables were connected during the measurement:

### Peripheral Devices

Device	Manufacturer	Model No.	Serial No.	FCC ID or DoC
Notebook Computer	I & B COM	Slim 5360	MB0VAA111100094	DOC
PRINTER	SEIKO EPSON CORP	EPSON STYLUS COLOR 460	BWCE143331	DOC
MOUSE (USB)	PANWEST	Cyber Beetle	PM1F154000055	DOC
Head phone	CAMAC	CMK-C3	-	-
Adaptor	HJC	JC-05015U	-	•

### □ Cable Description

#	Description	Ferrited	Length (m)	Other Details
1	AC power cable	-	-	Direct Plug-In type adaptor
2	AC power cable, Unshielded	No	1.8	Connect to AC power
3	Printer cable, Shielded	Yes	1.8	Between EUT and printer
4	USB cable, Shielded	No	1.5	Between EUT and notebook
5	RS232C cable, Shielded	No	2.5	Between EUT and notebook
6	Headset cable, Unshielded	No	1.8	-
7	Mouse cable, Shielded	No	1.8	Between EUT and USB mouse
8	LAN cable, Unshielded	No	20.0	Connect to HUB
9	DC output cable, Unshielded	No	1.8	-

n/a = not available

### 1.4 Test Software

	Pinging		
$\boxtimes$	Name -	Microsoft	ActiveSync

### 1.5 EUT Operating Mode(s)

Equipment under test was operated during the measurement under the following conditions:

Test program (H-Pattern)
Standby
Test program (color bar)
Test program (customer specific)
Practice operation - Data was communicated between the EUT and notebook.

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### 1.6 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

### 1.7 Test Facility

The measurement facility is located at 386-1, Ho-Dong, Yongin-City, Kyungki-Do, Korea 449-100. The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22.

### 1.8 Measurement Procedure

Preliminary AC power line conducted emissions tests were performed shielded room. To find worst mode, several typical mode and typical cable position were tested. Final AC power line conducted emissions test was performed shielded room. (location is same as Preliminary test)

Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

Preliminary radiated emissions test were performed anechoic chamber (Distance of antenna and EUT was 3 m). To find worst mode, several typical mode and typical cable position were tested and peak level and frequency were recorded.

Final radiated emissions test was performed Open Area Test Site. Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

\* Measurement procedures was In accordance with ANSI C63.4-1992 7.2.3, 7.2.4, 8.3.1.1, 8.3.1.2

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#### 1.9 **Laboratory Accreditations and Listings**

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 and 10 meter Open Area Test Sites to perform FCC Part 15/18 measurements.	FC 93250
JAPAN	VCCI	10 meter Open Area Test Site and one conducted site.	<b>P.948, C-986</b>
KOREA	MIC	EMI (CE, RE) EMS (ESD, Burst, RS, Surge, CS, Power-Frequency Susceptibility, Voltage Dips and Short Interruptions)	No. 51, KR0025
International	KOLAS	EMC	KOLAS NO-118
Europe	GLAS	EMC EN 55011, EN 55022, EN 55024, EN 61326, EN 50130-4, EN 50081-1, EN 50081-2, EN 50082-1, EN 50082-2, EN 61000-6-2, EN 61000-4-2, EN 61000-4-3, EN 61000-4-4, EN 61000-4-5, EN 61000-4-6, EN 61000-4-8, EN 61000-3-3	<b>TÜV</b> No.13000796-02

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### **Emissions Test Regulations**

The emissions tests were performed according	to following regulations:	
☐ EN 50081-1:1992		
☐ EN 55011:1998 +A1:1999	☐ Group 1 ☐ Class A	☐ Group 2 ☐ Class B
☐ EN 55013:1990 +A12:1994 +A13:1996 +A1 ☐ EN 55013:2001	4:1999	
☐ EN 55014-1:1993 +A1:1997 +A2:1999	☐ Household appliance☐ Portable tools☐ Semiconductor dev	
☐ EN 55014-1:2000 ☐ EN 55014-2:1997		
☐ EN 55015:1996 +A1:1997 +A2:1999 ☐ EN 55015:2000		
☐ EN 55020:1994 +A11:1996 +A13:1999 +A1 ☐ EN 55020:1994 +A11:1996 +A12:1999 +A1		
☐ EN 55022:1994 +A1:1995 +A2:1997 ☐ EN 55022:1998 +A1:2000	☐ Class A ☐ Class A	☐ Class B ☐ Class B
☐ EN 61000-3-2:1995 +A1:1998 +A2:1998 ☐ EN 61000-3-2:1995 +A1:1998 +A2:1998 +A2:198	A14: 2000	
☐ VCCI V-3/99.05 : 1999	☐ Class A	☐ Class B
☐ FCC Part 15 SUBPART B	☐ Class A	☐ Class B
☐ AS 3548 (1992)	☐ Class A	☐ Class B

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### 2.1 Conducted Voltage Emissions

#### **Test Date** July 11, 2002 **Test Location** EMI-CE: Shielded Room Test Instruments Rohde & Schwarz ESHS30 828144/002 **Test Accessories** $\square$ LISN **EMCO** 3825/2 9206-1971 **EMCO** 3825/2 9409-2246 3825/2 9607-2574 **EMCO** ☑ Control PC HP Vectra 500 SG72000192 **Frequency Range of Measurement** ☐ 450 kHz to 30 MHz Instrument Settings IF Band Width: 9 kHz **Test Results** The requirements are: minimum margin is 3.1 dBuV at 0.15 MHz NOT MET limit exceeded by maximum of \_\_\_\_ dBuV at \_\_\_\_ MHz

Remarks

☐ NOT APPLICABLE

See Appendix A for test data.

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### 2.2 Radiated Electric Field Emissions

#### **Test Date** July 26, 2002 **Test Location** ☑ EMI-OATS: Testing was performed at a test distance of 10 m. ☐ EMI-OATS: Testing was performed at a test distance of 3 m **Test Instruments** Rohde & Schwarz ESVS30 826638/008 **Test Accessories** ☑ ULTRA Broadband Antenna Rohde & Schwarz HL562 361324/014 ☐ Biconical Antenna Schwarzbeck BBA9106 41-00201 ☐ Biconical Antenna **EMCO** 9607-2564 3110B ☐ Log-periodic Antenna **EMCO** 3146 9607-4567 Frequency Range of Measurement 30 MHz to 1 GHz Instrument Settings IF Band Width: 120 kHz **Test Results** The requirements are: minimum margin is 3.0 dB (uV/m) at 215.6 MHz □ NOT MET limit exceeded by maximum of \_\_\_\_ dB(uV/m) at \_\_\_\_ MHz ☐ NOT APPLICABLE

Remarks

See Appendix A for test data

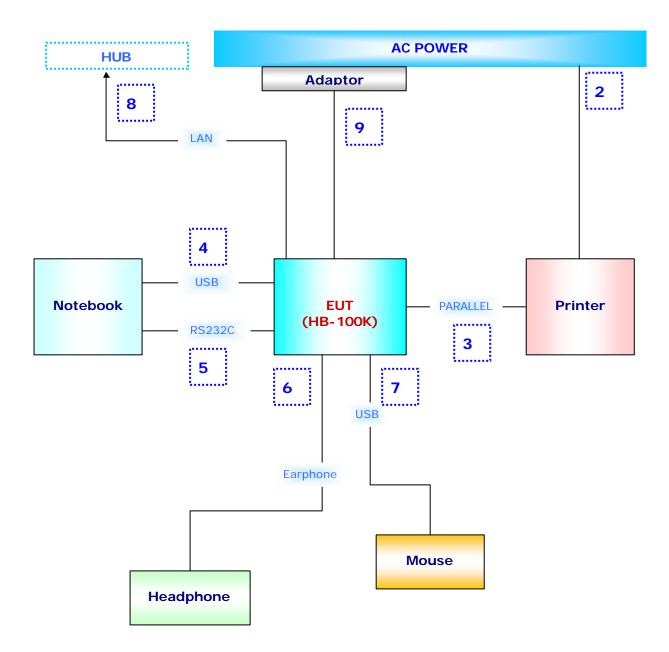
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### Configuration





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### APPENDIX A - TEST DATA

### Conducted Voltage Emissions (Quasi-Peak reading)

Frequency	Corre	rrection		Quasi-peak				Avei	rage		
. ,	Fac	tor	Line	Limit	Reading	Result	Margin	Limit	Reading	Result	Margin
[MHz]	LISN	Cable		[dBuV]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dB]
0.15	3.0	0.1	L	66.0	59.8	62.9	3.1				
0.18	3.0	0.1	L	64.7	58.3	61.4	3.4				
0.20	2.3	0.1	L	63.6	56.1	58.5	5.1				
0.22	2.3	0.1	L	62.8	55.2	57.6	5.2				
0.24	1.5	0.1	L	62.3	54.5	56.1	6.2				
0.25	1.5	0.1	L	61.8	52.4	54.0	7.8				
2.27	0.3	0.1	L					46.0	39.6	40.0	6.1
2.69	0.3	0.1	L					46.0	40.2	40.6	5.4
3.10	0.3	0.1	L					46.0	39.9	40.3	5.7
3.51	0.3	0.1	L					46.0	40.3	40.7	5.3
4.34	0.3	0.1	L					46.0	39.9	40.3	5.7
4.65	0.3	0.1	L					46.0	41.1	41.5	4.5
4.75	0.3	0.1	L					46.0	41.8	42.2	3.8
4.85	0.3	0.1	L					46.0	40.2	40.6	5.4

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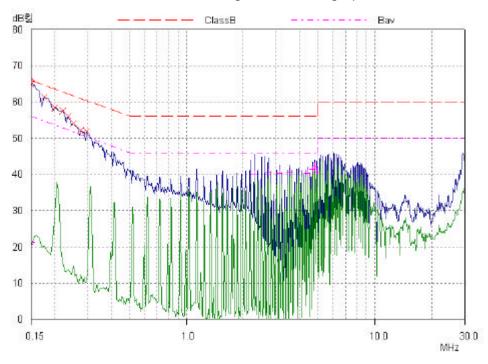
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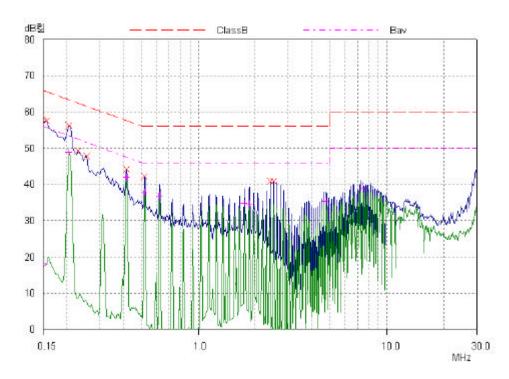


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#### (Peak and Average mode scan graph)





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### Radiated Electric Field Emissions (Quasi-Peak reading)

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Frequency	Reading	Pol.	Height	Correction Factor		Limits	Result	Margin
[MHz]	[dBuV/m]		[m]	Antenna	Cable	[dBuV/m]	[dBuV/m]	[dB]
48.20	13.8	V	1.0	9.60	1.30	30.0	24.72	5.28
113.70	12.3	V	1.0	9.55	2.00	30.0	23.83	6.17
203.50	13.6	V	1.0	7.35	2.80	30.0	23.78	6.22
206.90	16.4	Н	4.0	7.60	2.90	30.0	26.90	3.10
215.60	16.2	Н	4.0	7.90	2.90	30.0	27.00	3.00
239.00	13.3	Н	3.8	9.00	2.90	37.0	25.16	11.84
260.20	11.2	V	1.2	9.80	3.20	37.0	24.20	12.80
280.40	11.2	Н	4.0	10.40	3.40	37.0	24.99	12.01
287.90	11.0	Н	4.0	10.60	3.60	37.0	25.20	11.80
540.00	9.6	Н	4.0	16.10	4.80	37.0	30.48	6.52
699.00	5.1	Н	3.8	18.40	5.70	37.0	29.23	7.77

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